S	earch l	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/973,058	SAKURAI, TOSHIO	
Examiner	Art Unit	_
Mark R. Milia	2625	

	SEAR	CHED	
Class	Subclass	Date	Examiner
358	1.15	7/14/2005	мм
455	296	7/15/2005	ММ
382	260	7/15/2005	ММ

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
East Search	7/18/2005	ММ
IEEE	7/18/2005	ММ
Google	7/18/2005	ММ
East Search - see search history printout	3/15/2006	ММ
East - see search history printout	8/22/2006	ММ